

<b>Notice of References Cited</b>	Application/Control No. 10/517,860	Applicant(s)/Patent Under Reexamination ANNIC, ETIENNE	
	Examiner Khawar Iqbal	Art Unit 2686	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0039237	02-2003	FORSLOW, JAN E	370/352
	B	US-2002/0086670	07-2002	Rajaniemi et al.	455/426
	C	US-2001/0034228	10-2001	Lehtovirta et al.	455/424
	D	US-2002/0001291	01-2002	Willars et al.	370/329
	E	US-2002/0002591	01-2002	Ketola, Pekka	709/206
	F	US-6,792,278	09-2004	Ahmavaara et al.	455/461
	G	US-6,763,012	07-2004	Lord et al.	370/338
	H	US-2004/0054794	03-2004	Lantto et al.	709/229
	I	US-RE37,276	07-2001	Lantto, Jorgen	455/433
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.